

Slow Positron Beam Studies of the Stainless Steel Surface Exposed to Sandblasting

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The paper presents slow positron beam studies of the stainless steel grade 304 AISI samples annealed in the flow N₂ atmosphere and sandblasted under different pressure from 1 to 7 bar. Heating of specimens caused formation of an additional layer on the surface which can be identified as oxides. Sandblasting reduces the thickness of the oxide layer and also defects concentration (vacancies as we suppose) decreases in dependence on pressure applied during blasting. Additionally, the atomic concentrations of oxygen have been obtained using nuclear methods (Rutherford backscattering and nuclear reactions) in the near surface layers of the studied samples.

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1. Introduction

Positron annihilation spectroscopy (PAS) is a sensitive method for detection of open volume defects such as vacancies, vacancy clusters and nanovoids [1]. It allows to recognize defects sized from 0.1 to 1 nm and their concentrations at the level of 10⁻⁷. For detection of point defects PAS seems to be more effective than X-ray diffraction (XRD) [2], scanning (SEM) or transmission electron microscopy (TEM) [3]. Nowadays, slow positron beams allow to study the adjoined surface layer of *ca.* 1 μm thickness.

In this paper we point out that the slow positron beam applied to study samples of stainless steel grade 304 (AISI), which were annealed in a shield N₂ atmosphere and sandblasted, allows to observe interesting changes on the surface. Stainless steel is a material often studied using PAS as well. The main aim of these investigations is to find defects appearing in the samples as a result of different physical processes. In most cases specimens are specially prepared to get the well described structure before its modification.

For example, Wu and Yan [4] annealed the samples of stainless steel 304 at 1073 K for 15 min under vacuum of 10⁻³ Pa and next deformed by cold-rolling and charged electrolytically with hydrogen. They showed that hydrogen damage between the surface and the bulk has a significant variation with depth and strongly depends on the condition of hydrogen-charging. The voids close to

the surface and dislocations in the bulk after hydrogen-charging appeared.

Yabuuchi et al. [5] examined 304 AISI steel subjected to sensitization heat treatment, corrosion treatment and tensile plastic deformation. They noticed that the main source of defects such as vacancies is a plastic deformation. Additionally, they interpreted the observed defects as monovacancies, which were annealed at the temperature of 200–440 °C. However, to suppress chromium carbide participation, before deformations all the samples were annealed at 1150 °C for 2 h in vacuum silica tube and subsequently quenched into ice water. It was the reference state for specimens.

Wang et al. [6] tested 316L steel subjected to surface mechanical attrition treatment. They observed changes in configuration of defects after cyclical removal of the layers near the surface. Their samples were not thermally prepared to get the initial bulk state because they focused on the changes after etching.

Dryzek et al. [7] in SW18 steel, using slow positron beam, determined diffusion lengths for the samples subjected to friction. In our previous research we established the effect of friction on the creation of surface layer in 304 steel [8]. Using measurements made on standard sources of ²²Na and ⁶⁸Ge/⁶⁸Ga we observed that the depth of a defected layer depends on the load applied during sliding and that the shape of profiles of defect concentrations differs from corresponding profiles for pure iron [9]. Measurements of the positron lifetimes showed the formation of vacancies close to or at dislocations. The thickness of worn layer extended from 85 μm to 400 μm depending on the applied load during tribo-tests. The influence of various industrial cutting techniques on the range of

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formation of defects was also compared [10]. Samples, in our previous studies [8, 10], were annealed to get the non-defected bulk state. However, any changes on the surface connected with annealing could not be observed using standard experiments.

It is a well-known situation that if a metal is heated until it glows, in air atmosphere it reacts with oxygen and unwelcome oxides cover can be formed [11]. To protect the steel from such phenomenon the application of the shield atmospheres (such as nitrogen, argon, or hydrogen) is recommended but they do not give the 100% protection and their usage depends on the annealed alloy.

The aim of this work is to examine with the use of slow positron beam the subsurface regions of the samples annealed in N_2 and then sandblasted. Usually sandblasting, as the process of surface modification, is used to remove layers of oxides from the surfaces [12] or to create a desired surface texture. Diffusion of nitrogen atoms and then deformation induced by the sandblast treatment can generate a layer with defects. We are interested in the thickness of the layer and the defects concentration as well.

2. Experimental details

The object of the experiment were samples of stainless steel grade 304 AISI. The chemical composition is following: 0.06% C, 1% Si, 2.0% Mn, 0.04% P, 0.015% S, 0.1% N, 17.0% Cr, and 10% Ni. At the beginning specimens in the shape of small discs of 5 mm thickness and 10 mm in diameter were mechanically polished to get the most even, clear, and shiny surface. Afterwards, they were annealed for 1 h at a temperature of 700 °C in flow of 0.35 cm³/s atmosphere of N_2 . Subsequently all the samples were cooled to the room temperature in a furnace. As a result of heating, the surface of samples became similar to those presented by Naewkanya et al. [11], which suggests formation of oxides on the surface. The colourful layer was not removed. Such prepared samples were sandblasted using the Renfert Vario Basic Jet Blaster for 30 s under pressures of 1, 3, 5, and 7 bar. We applied NANODENTAL abrasive particles with the size of 110 μ m in diameter. The mixture consisted of Al_2O_3 (99.5%) and traces of SiO_2 , Fe_2O_3 , TiO_2 , CaO , Na_2O .

All samples have been tested on slow positron beam operating as a part of LEPTA project at JINR in Dubna [13]. The positrons are emitted from ^{22}Na source of 25 mCi activity and moderated onto frozen Ne (7 K) under pressure of 10^{-8} Torr. Moderated positrons are accelerated to the demanded energy in the range between 50 eV and 35 keV. They are implanted into the sample in the shape of a beam of 3 mm diameter and intensity of 10^5 e⁺/s. 511 keV quanta from the annihilation process are registered by Doppler broadening of annihilation gamma line spectrometer (DBGL) with 1.2 keV energy resolution interpolated to 511 keV.

From the measured lines the so-called S parameter was extracted. It is defined as a ratio of area under the central part of the annihilation line to the total surface area under this line. Integration area is established once for

all measurements. The S parameter is usually near 0.5. S parameter is strictly correlated with the type and concentration of defects, i.e. the higher its value, the bigger concentration of defects. It is the basic parameter calculated in analysing of data obtained from DBGL measurements.

It is known that some elements in examined samples such as Fe, Cr, Ni combine with oxygen easily and form stable oxides. To prove it, after PAS measurements we used Rutherford backscattering spectrometry (RBS) and nuclear reactions $^{16}O(\alpha, \alpha)^{16}O$ NR [14] to define concentration of oxygen in the near surface layer of the referential sample. The specimen was tested after annealing and after mechanical polishing of the surface. We polished the surface to remove visible changes on it created during heating. The RBS and $^{16}O(\alpha, \alpha)^{16}O$ NR measurements were carried out using a 3045 keV He⁺ ion beam and the scattering angle 170°.

3. Results and discussion

3.1. PAS results

Figure 1 shows the results of measurements using the variable energy positron beam for the referential sample (black circles) and samples sandblasted (white points) under different pressures. The calculated values of S parameter are presented as a function of positron incident. Estimation of the mean range of positron penetration was calculated as follows:

$$\bar{z} = \frac{A_{1/2}}{\rho} E^n, \quad (1)$$

where $\rho = 7.8$ g/cm³ is the density of material, $A_{1/2} = 2.39$ nm/keV ^{n} and $n = 1.692$ are the Makhov parameters for Fe [15]. Therefore, the minimal implantation depth for minimal energy used in experiment, it means 1 keV, is about 2.8 nm while the maximal depth equals approximately 1.3 μ m for 35 keV.

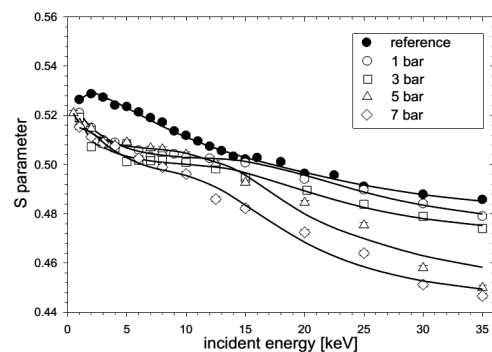


Fig. 1. The dependence of the measured S parameter on the positron energy for the reference sample (black circles) and the sandblasted ones under pressure 1 bar (white circles), 3 bar (white squares), 5 bar (white triangles) and 7 bar (white diamonds). The solid lines represent the best fit of model curves obtained from VEPFIT [16].

The shape of the received profiles, presented in Fig. 1 is not typical and differs significantly from the ones available in literature [5–7], but for the referential sample

(closed circles) there occurs the similarity between profile presented here and obtained by Wu et al. [17]. In their investigation the sample of pure iron was annealed at 1024 K for 15 min under a vacuum of 10^{-3} Pa, next mechanically polished to remove oxide layers and deformed by cold-rolling. After that, the specimen was corroded in the electrolyte solution of 1 N H_2SO_4 and distilled water under the anodic potential of 1.0 V for 10 min at room temperature. The measured S parameters points for corroded sample had much more values in comparison to only rolled specimen.

In our studies the S parameter profile for the referential sample lies under profiles of sandblasted ones. Additionally, we can observe ranges where decreasing S parameter has different slopes. Between energies of 2 keV and 15 keV it decreases linearly. At 16 keV energy there is another drop of a different kind, which seems to saturate at energies unavailable in this experiment. For the samples subjected to sandblasting (open symbols) layered character of profiles becomes more apparent. It indicates the existence of two layers of different properties. In the first

layer they decrease and saturate at about 5 keV energy, while in the further part, instead of maintaining S parameter values on a constant level, another drop occurs, which marks the beginning of another layer. The beginning of occurrence of another layer varies and depends on the pressure used during sandblasting. The bigger the sandblasting pressure the thinner the first layer. It is also worth pointing out that all the profiles for the sandblasted samples are located below the profiles for the referential sample.

The description of the presented S parameter profiles was performed with VEPFIT program [16], which is used to fit dependences of S parameters from energy through numerical solving of the positron diffusion equation. The implementation of double-layer model allowing to apply the implantation profile based on the Makhov parameters for Fe [15], made it possible to fit model function to the profiles represented by solid black lines in Fig. 1. The main adjustable parameters are the thickness of the first layer and the diffusion length and S_{layer} in both layers. The values of the parameters are gathered in Table.

TABLE

The values of the best fitted parameters in two layers obtained from the VEPFIT program [16] and calculated vacancies concentrations (in relative units: number of defects per number of atoms in the lattice) from Eq. (2).

Sample	1st layer				2nd layer		
	Thickness [nm]	L_+ [nm]	S_{layer}	C_v	L_+ [nm]	S_{layer}	C_v
reference	337(14)	23(1)	0.5081(7)	3.16×10^{-4}	44 ± 2	0.4838(8)	8.64×10^{-5}
1 bar	207(12)	42(4)	0.5110(5)	9.48×10^{-5}	54 ± 6	0.4822(9)	5.74×10^{-5}
3 bar	182(10)	44(5)	0.4986(4)	8.64×10^{-5}	70 ± 9	0.4786(9)	3.41×10^{-5}
5 bar	146(10)	52(7)	0.5050(5)	6.18×10^{-5}	75 ± 12	0.4593(9)	2.97×10^{-5}
7 bar	120(8)	54(4)	0.5048(5)	5.73×10^{-5}	79 ± 8	0.4438(9)	2.68×10^{-5}

Sandblasting causes the thickness of the first layer to diminish depending on the pressure applied during the process. The phenomenon can be explained by the fact that nitrogen atmosphere during annealing did not prevent formation of oxides or nitrides on the surface. Sandblasting, on the other hand, causes elimination of this layer. Lindell and Pettersson [12] studied different types of austenitic stainless steel annealed in production lines with the aim to characterize the oxides formation on the surface. They observed a thin multilayer of oxides lower than $1 \mu\text{m}$ in the case of cold rolling and next annealing of the stainless steel. In the case of the hot rolled and reheated material the thickness of oxides was bigger than $1 \mu\text{m}$. Additionally, they used shot blasting to remove the thickness of oxides.

Positron diffusion length presented in Table lengthens with the increase of pressure applied during sandblasting. In the work [18] Wu et al. present studies of samples of pure iron and SS 304 and 316 AISI electrocorroded under different potentials. They observed that changes of S parameter depend on the potentials and time. Additionally, they point out that corroded SS as well as iron

can produce vacancy-type defects. In the corroded iron both large-size defects (e.g voids) and small-size defects appear, while in SS only small-size defects occur. For these reasons we decided to calculate defects concentration only for vacancies. Using formula

$$C = \left[\left(\frac{L_{\text{bulk}}}{L_+} \right)^2 - 1 \right] / (\tau_{\text{bulk}}\mu), \quad (2)$$

where $\tau_{\text{bulk}} = 109.6$ ps [10], μ is the trapping coefficient for a single vacancy in pure Fe equal to $1.1 \times 10^{15} \text{ s}^{-1}$ [19], $L_{\text{bulk}} = 142$ nm [20] (the positron diffusion length in the bulk) the estimation is possible. The results of estimations for two layers are also presented in Table. Concentration of vacancies in both layers decreases with the increase of pressure applied during sandblasting. Sandblasting, therefore, seems to remove the surface layer that contains the defects created during annealing. It is an interesting result and needs more investigations especially for the deeper layer. On the other hand, the chemical etching for removing the first layer is also possible but it could introduce other changes and also the precise reduction would be very hard.

3.2. RBS and NR results

The typical spectra of scattered He^+ ions collected for investigated samples are presented in Fig. 2. The black circles represent the specimen which was only annealed and covered with, as we suppose, the oxide layer. In the measurements presented above it was called the referential sample. The white circles come from the same sample but after removing of the layer created during heating. It was done using mechanical polishing. The solid line represents the best fit of obtained spectra. A border near the energy of about 1100 keV was observed. It is presented in Fig. 2a. This bound corresponds to the scattered α particles on nucleus of oxygen atoms. That spectrum was measured for the referential sample (black circles). In Fig. 2b the part of the spectra of RBS in the region near the energy 1100 keV for both specimens is presented. It is found that the intensity of this line decreases in the collected spectrum measured for polished sample (white circles). The atomic concentration in the near surface layers was calculated using SIMNRA [21] and BS1 code [22]. It was determined that in the layer of 100 nm under surface the concentration of oxides in the annealed was about 40 times as much as in the layer of polished one.

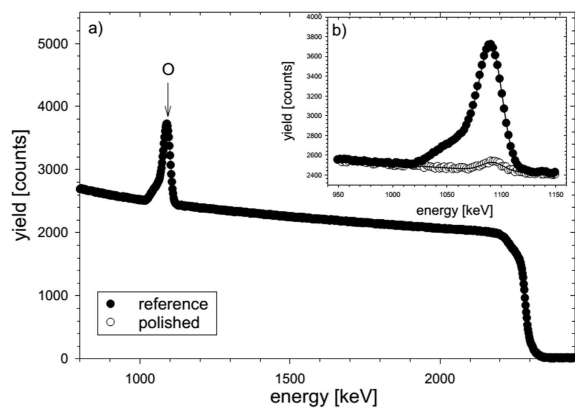


Fig. 2. RBS/NR spectra collected using a 3045 keV He^+ ion beam and the scattering angle 170° for sample after annealing called the reference sample (black circles) and the same sample after mechanical polishing (white circles). The solid line is the best fit of these spectra.

4. Conclusions

Nitrogen atmosphere during annealing seems to provide insufficient protection from formation of layers below the surface. The obtained profiles of S parameter reveal the existence of at least two layers. Sandblasting diminishes the thickness of the first layer depending on pressure used during the process. Annealing in nitrogen atmosphere created multilayer of oxides on surface of samples which consisted of defects and sandblasting removed this layer exposing less defected areas.

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